Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/644,276	RAO ET AL.
Examiner	Art Unit
Djenane M. Bayard	2141

Djenane M. Bayard

	SEARCHED			
Class	Subclass	Date	Examiner	
709	203	11/27/2007	DB	
705	80	11/27/2007	DB	
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INI	ERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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